

Insulated Gate Bipolar Transistor (Ultrafast Speed IGBT), 100 A



PRIMARY CHARACTERISTICS						
V _{CES}	600 V					
V _{CE(on)} (typical)	1.92 V					
V_{GE}	15 V					
I _C	100 A					
Speed	8 kHz to 30 kHz					
Package	SOT-227					
Circuit configuration	Single switch no diode					

FEATURES

 Ultrafast: optimized for minimum saturation voltage and speed up to 30 kHz in hard switching, > 200 kHz in resonant mode



- RoHS
- Very low conduction and switching losses
- Fully isolate package (2500 V_{AC/RMS})
- Very low internal inductance (≤ 5 nH typical)
- Industry standard outline
- UL approved file E78996
- Designed and qualified for industrial level
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

BENEFITS

- Designed for increased operating efficiency in power conversion: UPS, SMPS, welding, induction heating
- Lower overall losses available at frequencies = 20 kHz
- Easy to assemble and parallel
- Direct mounting to heatsink
- · Lower EMI, requires less snubbing
- Plug-in compatible with other SOT-227 packages

ABSOLUTE MAXIMUM RATINGS					
PARAMETER	SYMBOL	TEST CONDITIONS	MAX.	UNITS	
Collector to emitter breakdown voltage	V _{CES}		600	V	
Continuous collector current	I _C	T _C = 25 °C	200		
		T _C = 100 °C	100		
Pulsed collector current	I _{CM}		400	Α	
Clamped inductive load current	$V_{CC} = 80 \% (V_{CES}), V_{GE} = 20 \text{ V}, L = 10$ $R_g = 2.0 \Omega$, see fig. 13a		400		
Gate to emitter voltage	V_{GE}		± 20	V	
Reverse voltage avalanche energy	E _{ARV}	Repetitive rating; pulse width limited by maximum junction temperature	160	mJ	
RMS isolation voltage	V _{ISOL}	Any terminal to case, t = 1 min	2500	V	
Maximum power dissipation	P _D	T _C = 25 °C	500	W	
		T _C = 100 °C	200		
Operating junction and storage temperature range	T _J , T _{Stg}		-55 to +150	°C	
Mounting torque		6-32 or M3 screw	1.3 (12)	Nm (lbf.in)	

THERMAL AND MECHANICAL SPECIFICATIONS							
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS	
Junction and storage temperature range	T _J , T _{Stg}		-55	-	150		
Thermal resistance, junction to case	R _{thJC}		-	-	0.25	°C/W	
Thermal resistance case to heatsink	R _{thCS}	Flat, greased, surface	-	0.05	-		
Weight			-	30	-	g	
Mounting torque		Torque to terminal	-	-	1.1 (9.7)	Nm (lbf.in)	
		Torque to heatsink	-	-	1.8 (15.9)	Nm (lbf.in)	
Case style			SOT-227				



ELECTRICAL SPECIFICATIONS (T _J = 25 °C unless otherwise specified)							
PARAMETER	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNITS	
Collector to emitter breakdown voltage	V _{(BR)CES}	V _{GE} = 0 V, I _C = 250 μA		600	-	-	
Emitter to collector breakdown voltage	V _{(BR)ECS}	$V_{GE} = 0 \text{ V}, I_{C} = 1.0 \text{ A}$ Pulse width $\leq 80 \mu\text{s}; \text{ duty}$	18	ı	I	V	
Temperature coefficient of breakdown voltage	$\Delta V_{(BR)CES}/\Delta T_{J}$	V _{GE} = 0 V, I _C = 10 mA		-	0.38	-	V/°C
Collector to emitter saturation voltage	V _{CE(on)}	I _C = 100 A	V _{GE} = 15 V See fig. 2, 5	ı	1.60	1.9	V
		I _C = 200 A		ı	1.92	-	
		$I_C = 100 \text{ A}, T_J = 150 ^{\circ}\text{C}$	000 fig. 2, 5	ı	1.54	-	
Gate threshold voltage	V _{GE(th)}	$V_{CE} = V_{GE}, I_{C} = 250 \mu A$	$V_{CE} = V_{GE}, I_{C} = 250 \mu\text{A}$			6.0	
Temperature coefficient of threshold voltage	$\Delta V_{GE(th)}/\Delta T_J$	$V_{CE} = V_{GE}$, $I_C = 2.0 \text{ mA}$		-	-11	-	mV/°C
Forward transconductance	g _{fe}	$V_{CE} = 100 \text{ V}, I_{C} = 100 \text{ A}$ Pulse width 5.0 µs, single shot		79	-	-	S
Zero gate voltage collector current	I _{CES}	$V_{GE} = 0 \text{ V}, V_{CE} = 600 \text{ V}$		-	-	1.0	mΛ
		$V_{GE} = 0 \text{ V}, V_{CE} = 600 \text{ V}, T_{J} = 150 ^{\circ}\text{C}$		-	-	10	mA
Gate to emitter leakage current	I _{GES}	$V_{GE} = \pm 20 \text{ V}$		-	-	± 250	nA

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS
Total gate charge (turn-on)	Q_g	I _C = 100 A	-	770	1200	
Gate-emitter charge (turn-on)	Q _{ge}	V _{CC} = 400 V	-	100	150	nC
Gate-collector charge (turn-on)	Q _{gc}	V _{GE} = 15 V; See fig. 8	-	260	380	
Turn-on delay time	t _{d(on)}	T _J = 25 °C	-	54	-	- ns
Rise time	t _r	I _C = 100 A	-	79	-	
Turn-off delay time	t _{d(off)}	V _{CC} = 480 V	-	130	200	
Fall time	t _f	V _{GE} = 15 V	-	300	450	
Turn-on switching loss	E _{on}	$R_g = 2.0 \Omega$ Energy losses include "tail" See fig. 9, 10, 14	-	0.98	-	mJ
Turn-off switching loss	E _{off}		-	3.48	-	
Total switching loss	E _{ts}		-	4.46	7.6	
Turn-on delay time	t _{d(on)}	T _J = 150 °C	-	56	-	
Rise time	t _r	I _C = 100 A, V _{CC} = 480 V	-	75	-	
Turn-off delay time	t _{d(off)}	V_{GE} = 15 V, R_g = 2.0 Ω Energy losses include "tail"	-	160	-	ns
Fall time	t _f		-	460	-	
Total switching loss	E _{ts}	See fig. 10, 11, 14	-	7.24	-	mJ
Internal emitter inductance	LE	Measured 5 mm from package	-	5.0		nΗ
Input capacitance	C _{ies}	V _{GE} = 0 V	-	16 500	-	
Output capacitance	C _{oes}	V _{CC} = 30 V	-	1000	-	рF
Reverse transfer capacitance	C _{res}	f = 1.0 MHz; See fig. 7	-	200	-	1



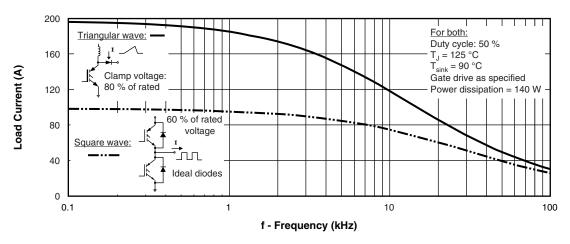


Fig. 1 - Typical Load Current vs. Frequency (Load Current = I_{RMS} of Fundamental)

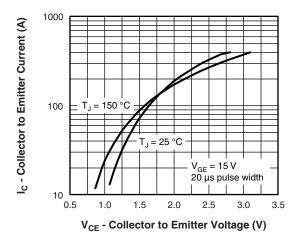


Fig. 2 - Typical Output Characteristics

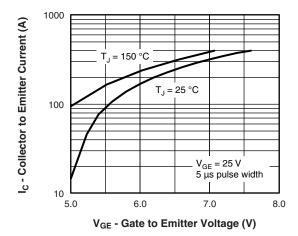


Fig. 3 - Typical Transfer Characteristics

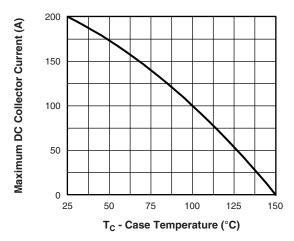


Fig. 4 - Maximum Collector Current vs. Case Temperature

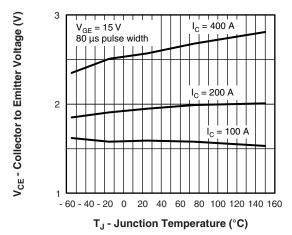


Fig. 5 - Typical Collector to Emitter Voltage vs. Junction Temperature



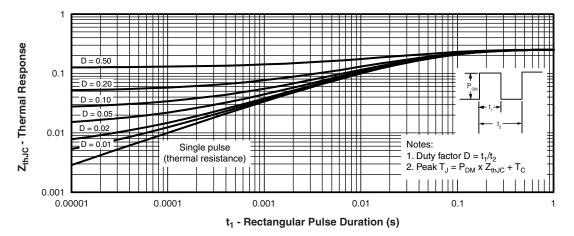


Fig. 6 - Maximum Effective Transient Thermal Impedance, Junction to Case

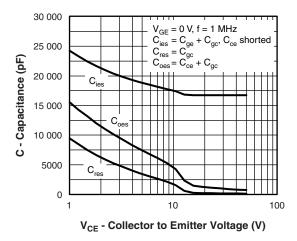


Fig. 7 - Typical Capacitance vs. Collector to Emitter Voltage

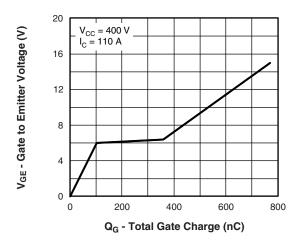


Fig. 8 - Typical Gate Charge vs. Gate to Emitter Voltage

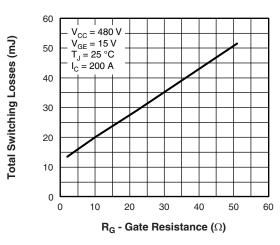


Fig. 9 - Typical Switching Losses vs. Gate Resistance

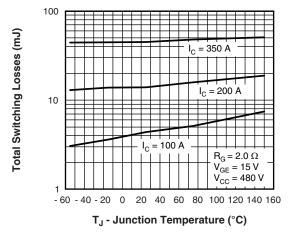


Fig. 10 - Typical Switching Losses vs. Junction Temperature

www.vishay.com

Vishay Semiconductors

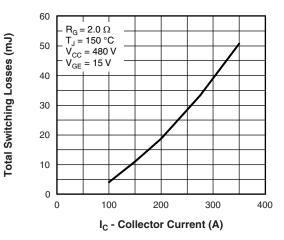


Fig. 11 - Typical Switching Losses vs. Collector Current

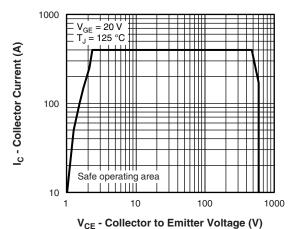
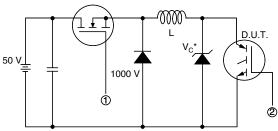


Fig. 12 - Turn-Off SOA



 * Driver same type as D.U.T.; $\rm V_{C}$ = 80 % of $\rm V_{CE}$ (max)

Note: Due to the 50 V power supply, pulse width and inductor will increase to obtain rated I_d

Fig. 13a - Clamped Inductive Load Test Circuit

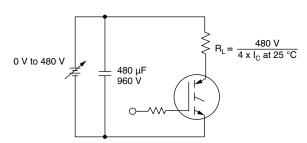


Fig. 13b - Pulsed Collector Current Test Circuit

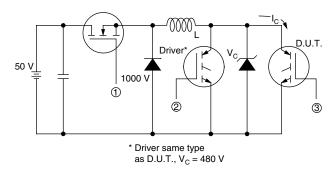


Fig. 14a - Switching Loss Test Circuit

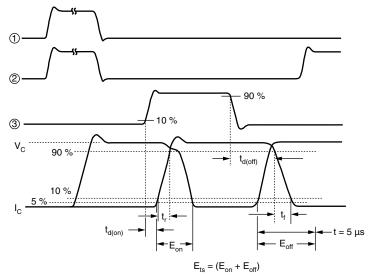
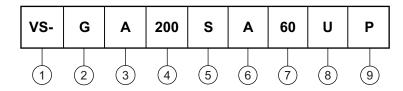


Fig. 14b - Switching Loss Waveforms

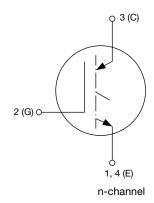
ORDERING INFORMATION TABLE

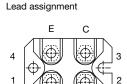
Device code



- Vishay Semiconductors product
- Insulated gate bipolar transistor (IGBT)
- 3 Generation 4, IGBT silicon, DBC construction
- Current rating (200 = 200 A)
- 5 Single switch no diode
- 6 SOT-227
- 7 Voltage rating (60 = 600 V)
- Speed/type (U = ultrafast)
- 9 None = standard production
 - P = lead (Pb)-free

CIRCUIT CONFIGURATION





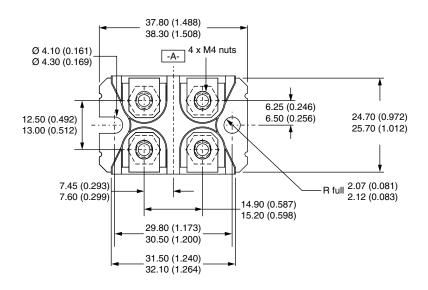
 LINKS TO RELATED DOCUMENTS

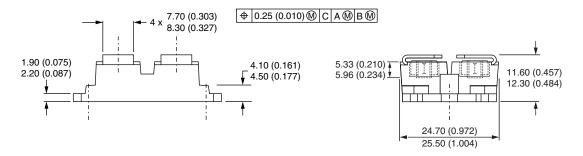
 Dimensions
 www.vishay.com/doc?95425

 Packaging information
 www.vishay.com/doc?95423

SOT-227 Generation 2

DIMENSIONS in millimeters (inches)





Note

· Controlling dimension: millimeter



Vishay

Disclaimer

ALL PRODUCT, PRODUCT SPECIFICATIONS AND DATA ARE SUBJECT TO CHANGE WITHOUT NOTICE TO IMPROVE RELIABILITY, FUNCTION OR DESIGN OR OTHERWISE.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained in any datasheet or in any other disclosure relating to any product.

Vishay makes no warranty, representation or guarantee regarding the suitability of the products for any particular purpose or the continuing production of any product. To the maximum extent permitted by applicable law, Vishay disclaims (i) any and all liability arising out of the application or use of any product, (ii) any and all liability, including without limitation special, consequential or incidental damages, and (iii) any and all implied warranties, including warranties of fitness for particular purpose, non-infringement and merchantability.

Statements regarding the suitability of products for certain types of applications are based on Vishay's knowledge of typical requirements that are often placed on Vishay products in generic applications. Such statements are not binding statements about the suitability of products for a particular application. It is the customer's responsibility to validate that a particular product with the properties described in the product specification is suitable for use in a particular application. Parameters provided in datasheets and / or specifications may vary in different applications and performance may vary over time. All operating parameters, including typical parameters, must be validated for each customer application by the customer's technical experts. Product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein.

Except as expressly indicated in writing, Vishay products are not designed for use in medical, life-saving, or life-sustaining applications or for any other application in which the failure of the Vishay product could result in personal injury or death. Customers using or selling Vishay products not expressly indicated for use in such applications do so at their own risk. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay. Product names and markings noted herein may be trademarks of their respective owners.

单击下面可查看定价,库存,交付和生命周期等信息

>>Vishay(威世)